

**Search Notes**

Application/Control No.

10/064,582

Examiner

Dipakkumar Gandhi

Applicant(s)/Patent under  
Reexamination

GOODNOW ET AL.

Art Unit

2138

**SEARCHED**

Class	Subclass	Date	Examiner
714	798	3/15/2006	DG
714	789	3/15/2006	DG
714	744	3/15/2006	DG
714	739	3/15/2006	DG
714	715	3/15/2006	DG
714	737	3/15/2006	DG
714	735	3/15/2006	DG
713	600	3/15/2006	DG
713	500	3/15/2006	DG
713	401	3/15/2006	DG
714	815	3/15/2006	DG
714	814	3/15/2006	DG
714	731	3/15/2006	DG
714	707	3/15/2006	DG

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
USPAT	text	3/15/2006	DG
PGPUB	text	3/15/2006	DG

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East database was searched. Search history is attached.	3/15/2006	DG
Inventor search was conducted. There is no double patenting.	3/15/2006	DG
Full text Patent files search by EIC 2100. Search history is attached.	3/14/2006	DG
Full text Non Patent Literature (NPL) files search by EIC 2100. Search history is attached.	3/14/2006	DG
Bib. Non Patent Literature (NPL) files search by EIC 2100. Search history is attached.	3/14/2006	DG
Bib. Patent files search by EIC 2100. Search history is attached.	3/14/2006	DG
US-PGPUB, USPAT text search, see interference search printout.	3/15/2006	DG
Consulted Christine Tu (primary examiner) for search	3/14/2006	DG

**Search Notes (continued)**

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Class	Subclass	Date	Examiner
714	55	3/15/2006	DG
710	58	3/15/2006	DG
710	61	3/15/2006	DG
709	232	3/15/2006	DG
709	233	3/15/2006	DG
702	125	3/15/2006	DG
324	73.1	3/15/2006	DG
326	16	3/15/2006	DG

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East database was searched. Search history is attached.	3/15/2006	DG
IEEE Xplore. Search history is attached.	3/10/2006	DG